



IN THE UNITED STATES PATENT AND
TRADEMARK OFFICE

Minneapolis, Minnesota

Applicant - IOANNIS PAVLIDIS

Group - 2859

Serial No. - 10/008,392

Examiner -

Filed - November 13, 2001

Atty. Docket No. - H0002443-01

For - SYSTEM AND METHOD USING THERMAL IMAGE ANALYSIS FOR
POLYGRAPH TESTING

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents-

Washington, D. C. 20231

Dear Sir:

Pursuant to the provisions of CFR §1.97(e)(1), each item of information contained in this information disclosure statement was first cited in a communication from a foreign patent office in a counterpart application not more than three (3) months prior to the filing of this information disclosure statement. A copy of the International Search Report and cited references are enclosed.

Respectfully submitted for
IOANNIS PAVLIDIS

Kris T. Fredrick
Registration No. 42,554

Date: 10/16/02
Enclosure

#2857
#3775
PATENT
10/28/02

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